



SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT

Applicant : Bogdan C. Maglich
App. No. : 09/883,851
Filed : June 18, 2001
For : METHOD AND APPARATUS FOR
NEUTRON MICROSCOPY WITH
STOICHIOMETRIC IMAGING
Examiner : Jack W. Keith
Group Art Unit : 3641

Mail Stop Amendment
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Enclosed is form PTO-1449 listing one (1) reference that is also enclosed.

This Supplemental Information Disclosure Statement is being filed after the mailing date of a final action under 37 C.F.R. § 1.113. This Statement is accompanied by the fee set forth in 37 C.F.R. § 1.17(p). The Commissioner is hereby authorized to charge any additional fees which may be required or to credit any overpayment to Account No. 11-1410. A certification under 37 C.F.R. § 1.97(e) is set forth below.

CERTIFICATION UNDER 37 C.F.R. § 1.97(e)(2)

I hereby certify that no item of information contained in this Statement was cited in a communication from a foreign Patent Office in a counterpart foreign application, and, to my knowledge after making reasonable inquiry, was known to any individual designated in 37 C.F.R. § 1.56(c) more than 3 months prior to the filing of this Supplemental Information Disclosure Statement.

Appl. No. : 09/883,851
Filed : June 18, 2001

Docket No. HIENER.1CPC1CP
Customer No. 20,995

Respectfully submitted,

KNOBBE, MARTENS, OLSON & BEAR, LLP

Dated: _____

8/26/04

By: _____

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FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
HIENER.1CPC1CPAPPLICATION NO.
09/883,851INFORMATION DISCLOSURE STATEMENT
BY APPLICANT

(USE SEVERAL SHEETS IF NECESSARY)

APPLICANT
Bogdan C. MaglichFILING DATE
June 18, 2001GROUP
3641

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO

EXAMINER
INITIAL

OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

Beyerle, Albert, et al., *Design of an associated particle imaging system*, Nuclear Instruments and Methods in Physics Research A299 (1990), pp. 458-462.H:\DOCS\BS\BSI-6585.DOC
082604

EXAMINER

DATE CONSIDERED

*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.